## **TOSHIBA**

TOSHIBA Field Effect Transistor Silicon N Channel MOS Type (兀MOS )

# 2SK3762

#### **Switching Regulator Applications**

- Low drain-source ON resistance: RDS (ON) = 5.6 (typ.)
- High forward transfer admittance:  $|Y_{fS}| = 2.0 \text{ S (typ.)}$
- Low leakage current:  $IDSS = 100 \mu A (VDS = 720 V)$
- Enhancement-mode:  $V_{th} = 2.0 \sim 4.0 \text{ V}$  ( $V_{DS} = 10 \text{ V}$ ,  $I_{D} = 1 \text{ mA}$ )

#### Maximum Ratings (Ta = 25°C)

Characte	ristics	Symbol	Rating	Unit
Drain-source voltage		$V_{DSS}$	900	V
Drain-gate voltage (F	$R_{GS} = 20 \text{ k}\Omega$	$V_{DGR}$	900	V
Gate-source voltage		$V_{GSS}$	±30	٧
	DC (Note 1)	lD	2.5	Α
Drain current	Pulse (t = 1 ms) (Note 1)	l <sub>DP</sub>	7.5	
Drain power dissipat	ion (Tc = 25°C)	$P_{D}$	62	W
Single pulse avalance	he energy (Note 2)	E <sub>AS</sub> 21.6		ъ
Avalanche current		l <sub>AR</sub>	ataSheet4U.c	am A
Repetitive avalanche	energy (Note 3)	E <sub>AR</sub>	E <sub>AR</sub> 6.2	
Channel temperature	)	T <sub>ch</sub>	150	°C
Storage temperature	range	T <sub>stg</sub>	-55~150	°C

#### **Thermal Characteristics**

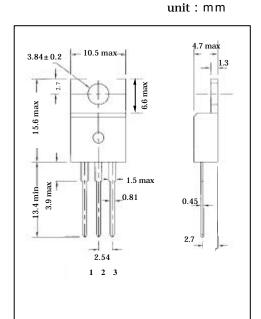
Characteristics	Symbol	Max	Unit
Thermal resistance, channel to case	R <sub>th (ch-c)</sub>	2.02	°C/W
Thermal resistance, channel to ambient	R <sub>th (ch-a)</sub>	83.3	°C/W

Note 1: Please use devices on conditions that the channel temperature is below 150 °C.

Note 2:  $V_{DD}$  = 90 V,  $T_{ch}$  = 25°C, L = 6.3 mH,  $I_{AR}$  = 2.5 A,  $R_G$  = 25  $\Omega$ 

Note 3: Repetitive rating: Pulse width limited by maximum channel temperature

This transistor is an electrostatic sensitive device. Please handle with caution.

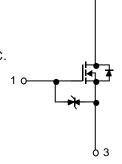


- 1. Gate
- 2. Drain(HEAT SINK)
- 3. Source

JEDEC	TO-220AB
JEITA	SC-46
TOSHIBA	

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Weight: 2.0g(typ.)



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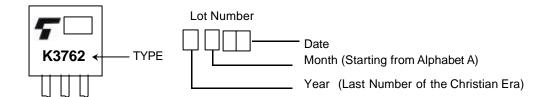
### Electrical Characteristics (Ta = 25°C)

Characteristics		Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage cu	eakage current $I_{GSS}$ $V_{GS} = \pm 30 \text{ V}, V_{DS} = 0 \text{ V}$		_	_	±10	μΑ	
Gate-source bre	Gate-source breakdown voltage V (BR) GSS		$I_D = \pm 10 \ \mu A, \ V_{GS} = 0 \ V$	±30	_	_	V
Drain cut-off curi	rent	I <sub>DSS</sub>	$V_{DS} = 720 \text{ V}, V_{GS} = 0 \text{ V}$	_	_	100	μΑ
Drain-source bre	akdown voltage	V (BR) DSS	$I_D = 10 \text{ mA}, V_{GS} = 0 \text{ V}$	900	_	_	V
Gate threshold v	oltage	$V_{th}$	$V_{DS} = 10 \text{ V}, I_D = 1 \text{ mA}$	2.0	_	4.0	V
Drain-source ON	l resistance	R <sub>DS (ON)</sub>	$V_{GS} = 10 \text{ V}, I_D = 1.5 \text{ A}$	_	5.6	6.4	Ω
Forward transfer	admittance	Y <sub>fs</sub>	$V_{DS} = 20 \text{ V}, I_D = 1.5 \text{ A}$	1.0	2.0	_	S
Input capacitano	e	C <sub>iss</sub>		_	470	_	
Reverse transfer capacitance		C <sub>rss</sub>	$V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	_	10	_	pF
Output capacitance		C <sub>oss</sub>			50	_	
Switching time	Rise time	t <sub>r</sub>	$\begin{array}{c c} 10 \text{ V} \\ \text{VGS} \\ 0 \text{ V} \\ \hline \\ 50  \\ \hline \\ \end{array} \begin{array}{c} \text{I}_D = 1.5 \text{ A} \\ \text{V}_{OUT} \\ \hline \\ \end{array} \begin{array}{c} \text{R}_L = \\ 133  \\ \text{V}_{DD} \approx 200 \text{ V} \\ \end{array}$	_	20		
	Turn-on time	t <sub>on</sub>		_	60		20
	Fall time	t <sub>f</sub>			30		ns
	Turn-off time	t <sub>off</sub>		_	100	_	
Total gate charge		Qg		_	12	_	
Gate-source charge		Q <sub>gs</sub>	$V_{DD} \simeq 400 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 2.5 \text{ A}$		7		nC
Gate-drain charge		Q <sub>gd</sub>	]		5		

### **Source-Drain Ratings and Characteristics (Ta = 25°C)**

Characteristics		Symbol	Test Condition	Min	Тур.	Max	Unit
Continuous drain reverse current (N	Note 1)	l <sub>DR</sub>	_			2.5	Α
Pulse drain reverse current (N	Note 1)	I <sub>DRP</sub>	_	_	_	7.5	Α
Forward voltage (diode)		$V_{DSF}$	$I_{DR} = 2.5 \text{ A}, V_{GS} = 0 \text{ V}$	_	_	-1.7	V
Reverse recovery time		t <sub>rr</sub>	$I_{DR} = 2.5 \text{ A}, V_{GS} = 0 \text{ V},$	_	720	_	ns
Reverse recovery charge		$Q_{rr}$	$dI_{DR}/dt = 100 A/\mu s$	_	3.6	_	μC

### Marking



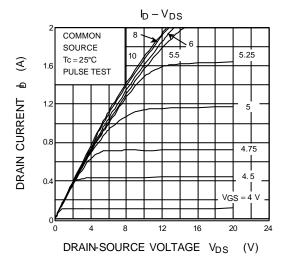
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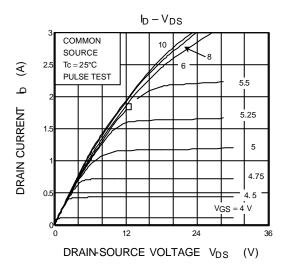
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COMMON SOURCE

VDS = 20 V

PULSE TEST

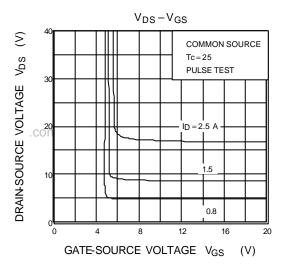
100

TC = -55°C

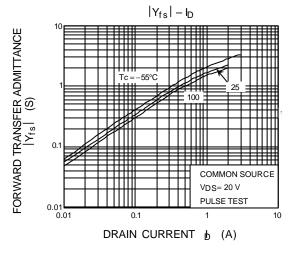
Date

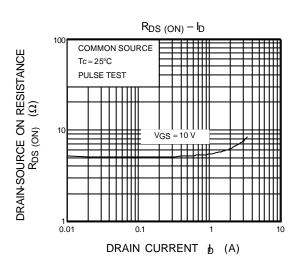
GATE-SOURCE VOLTAGE VGS (V)

 $I_D - V_{GS}$ 



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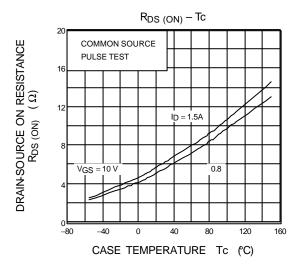
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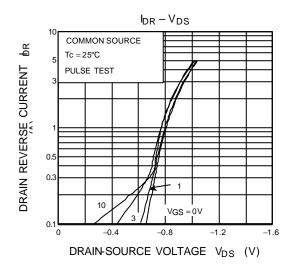
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CAPACITANCE - V<sub>DS</sub>

1000

1000

Ciss

Coss

taSh

Common source

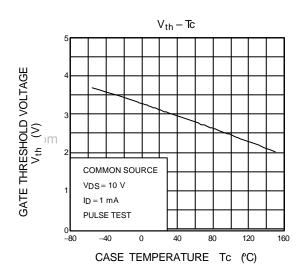
VGS = 0 V

f = 1 MHz

Tc = 25°C

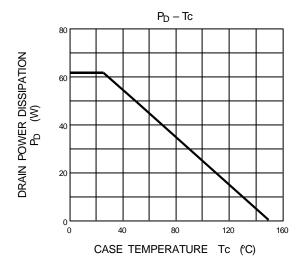
10.1 1 3 5 10 30 50 100

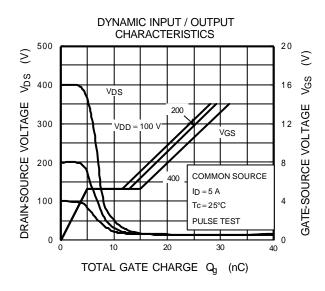
DRAIN-SOURCE VOLTAGE V<sub>DS</sub> (V)



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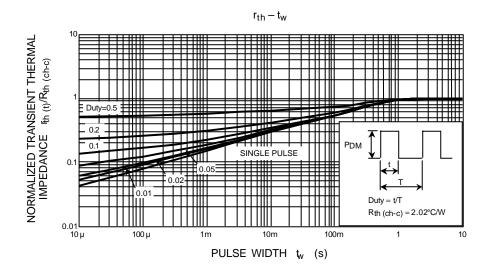


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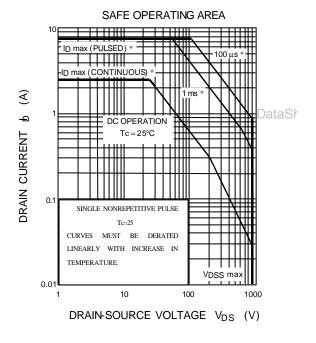
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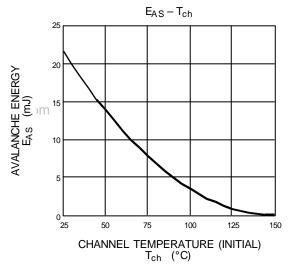
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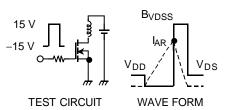
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$$\begin{array}{ll} R_G = 25~\Omega \\ V_{DD} = 90~V,~L = 6.3~mH \end{array} \qquad \mathring{A}_{AS} = \frac{1}{2} \cdot L \cdot I^2 \cdot \left( \frac{BVDSS}{BVDSS - V_{DD}} \right)$$

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